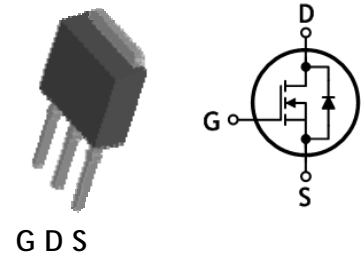


SWITCHING REGULATOR APPLICATION

Features

- Drain-Source breakdown voltage: $BV_{DSS}=600V$ (Min.)
- Low gate charge: $Q_g=12nC$ (Typ.)
- Low drain-source On resistance: $R_{DS(on)}=2.1\Omega$ (Typ.)
- 100% avalanche tested
- RoHS compliant device

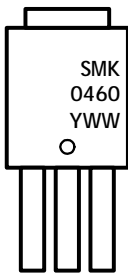


Ordering Information

Part Number	Marking	Package
SMK0460IS	SMK0460	I-PAK (Short Lead)

I-PAK

Marking Information



Column 1, 2: Device Code
 Column 3: Production Information
 e.g.) YWW
 -. Y: Year Code
 -. WW: Week Code

Absolute maximum ratings ($T_C=25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit	
Drain-source voltage	V_{DSS}	600	V	
Gate-source voltage	V_{GSS}	± 30	V	
Drain current (DC) *	I_D	$T_C=25^\circ C$	4	A
		$T_C=100^\circ C$	2.53	A
Drain current (Pulsed) *	I_{DM}	16	A	
Avalanche current ^(Note 2)	I_{AS}	4	A	
Single pulsed avalanche energy ^(Note 2)	E_{AS}	225	mJ	
Repetitive avalanche current ^(Note 1)	I_{AR}	4	A	
Repetitive avalanche energy ^(Note 1)	E_{AR}	10	mJ	
Power dissipation	P_D	48	W	
Junction temperature	T_J	150	$^\circ C$	
Storage temperature range	T_{stg}	-55~150	$^\circ C$	

* Limited only maximum junction temperature

Thermal Characteristics

Characteristic	Symbol	Rating	Unit
Thermal resistance, junction to case	$R_{th(j-c)}$	Max. 2.6	°C/W
Thermal resistance, junction to ambient	$R_{th(j-a)}$	Max. 62.5	

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0$	600	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$I_D=250\mu\text{A}$, $V_{DS}=V_{GS}$	2.0	-	4.0	V
Drain-source cut-off current	I_{DSS}	$V_{DS}=600\text{V}$, $V_{GS}=0\text{V}$	-	-	1	μA
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 30\text{V}$	-	-	± 100	nA
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}$, $I_D=2\text{A}$	-	2.1	2.5	Ω
Internal gate resistance	R_G	$f=1\text{MHz}$, $V_{DS}=0\text{V}$	-	1.25	6.25	Ω
Forward transfer conductance (Note 3)	g_{fs}	$V_{DS}=10\text{V}$, $I_D=2\text{A}$	-	4.0	-	S
Input capacitance	C_{iss}	$V_{DS}=25\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$	-	670	848	pF
Output capacitance	C_{oss}		-	57	71	
Reverse transfer capacitance	C_{rss}		-	9.8	12.2	
Turn-on delay time (Note 3,4)	$t_{d(on)}$	$V_{DD}=300\text{V}$, $I_D=4\text{A}$ $R_G=25\Omega$	12	25	38	ns
Rise time (Note 3,4)	t_r		14	28	42	
Turn-off delay time (Note 3,4)	$t_{d(off)}$		55	110	165	
Fall time (Note 3,4)	t_f		18	36	54	
Total gate charge (Note 3,4)	Q_g	$V_{DS}=480\text{V}$, $V_{GS}=10\text{V}$ $I_D=4\text{A}$	-	12	15	nC
Gate-source charge (Note 3,4)	Q_{gs}		-	4	-	
Gate-drain charge (Note 3,4)	Q_{gd}		-	3	-	

Source-Drain Diode Ratings and Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	I_S	Integral reverse diode in the MOSFET	-	-	4	A
Source current (Pulsed)	I_{SM}		-	-	16	A
Forward voltage	V_{SD}	$V_{GS}=0\text{V}$, $I_S=4\text{A}$	-	-	1.4	V
Reverse recovery time (Note 3,4)	t_{rr}	$I_S=4\text{A}$, $V_{GS}=0\text{V}$ $di_S/dt=-100\text{A}/\mu\text{s}$	-	300	-	ns
Reverse recovery charge (Note 3,4)	Q_{rr}		-	2.2	-	μC

Note:

1. Repeated rating: Pulse width limited by safe operating area
2. $L=25.9\text{mH}$, $I_{AS}=4\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$
3. Pulse test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
4. Essentially independent of operating temperature typical characteristics

Electrical Characteristic Curves

Fig. 1 $I_D - V_{DS}$

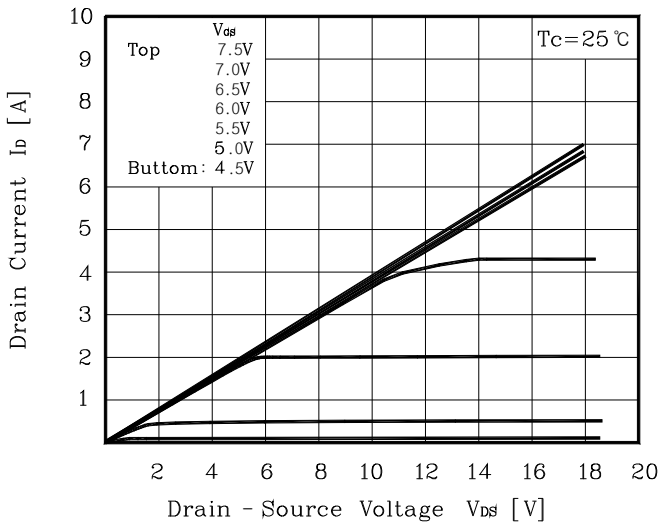


Fig. 2 $I_D - V_{GS}$

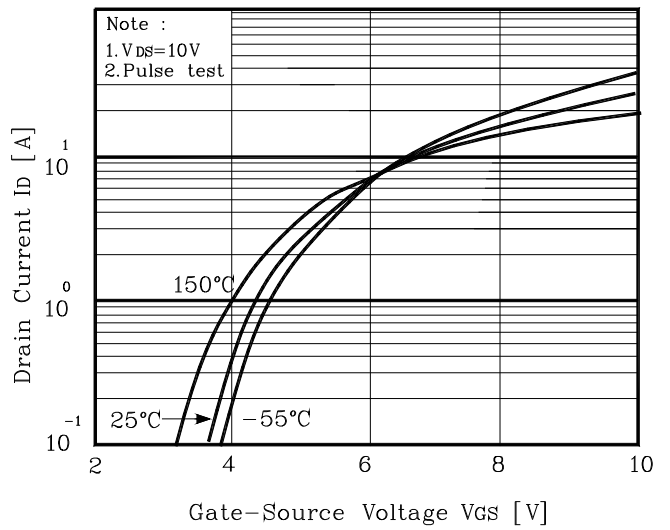


Fig. 3 $R_{DS(ON)} - I_D$

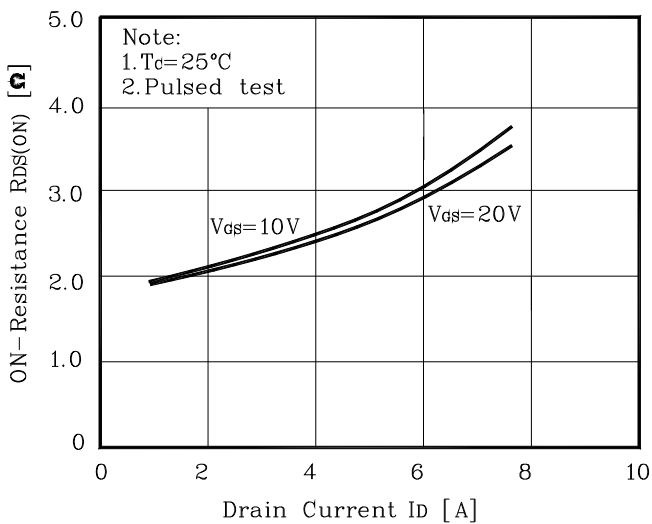


Fig. 4 $I_S - V_{SD}$

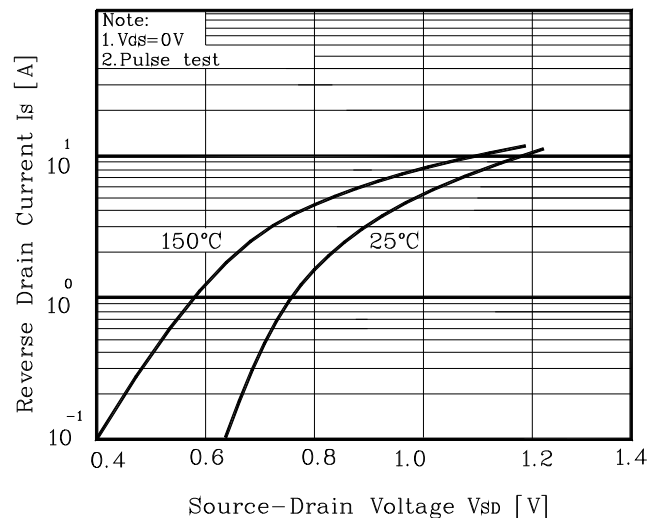


Fig. 5 Capacitance - V_{DS}

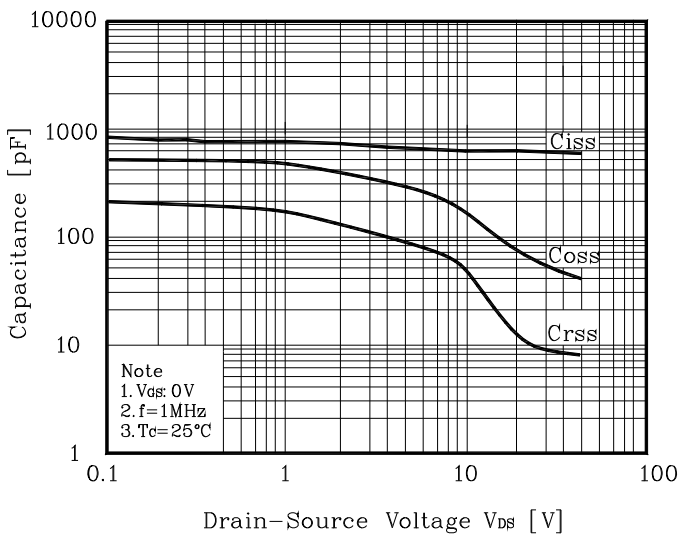
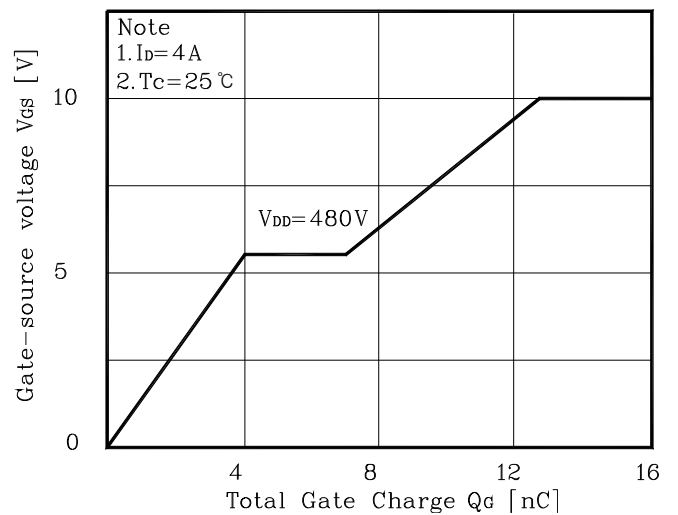


Fig. 6 $V_{GS} - Q_G$



Electrical Characteristic Curves (Continue)

Fig. 7 $BV_{DSS} - T_J$

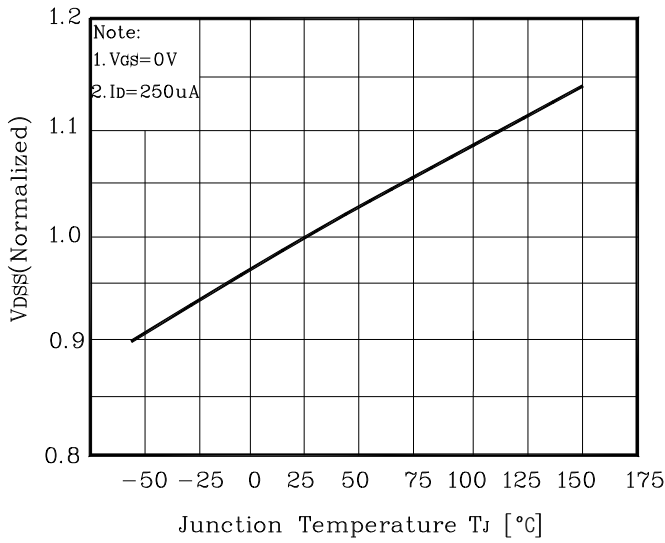


Fig. 8 $R_{DS(ON)} - T_J$

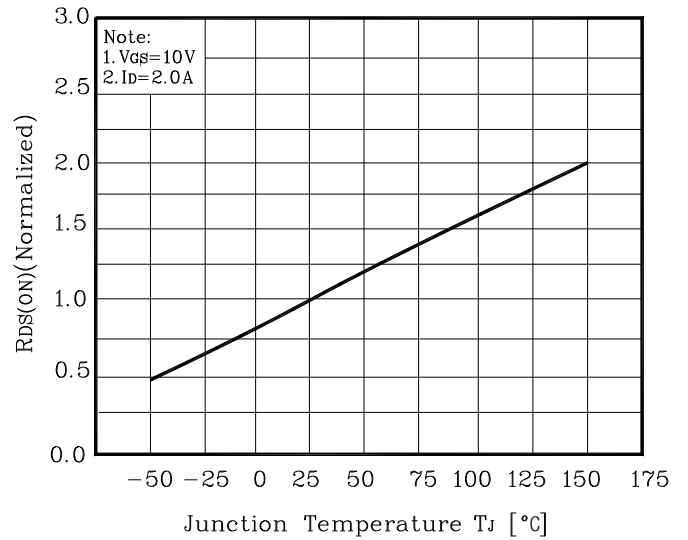


Fig. 9 $I_D - T_C$

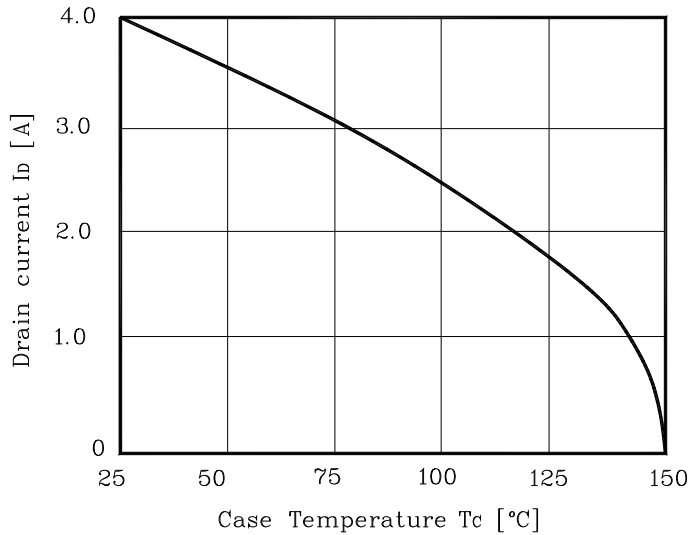


Fig. 10 Safe Operating Area

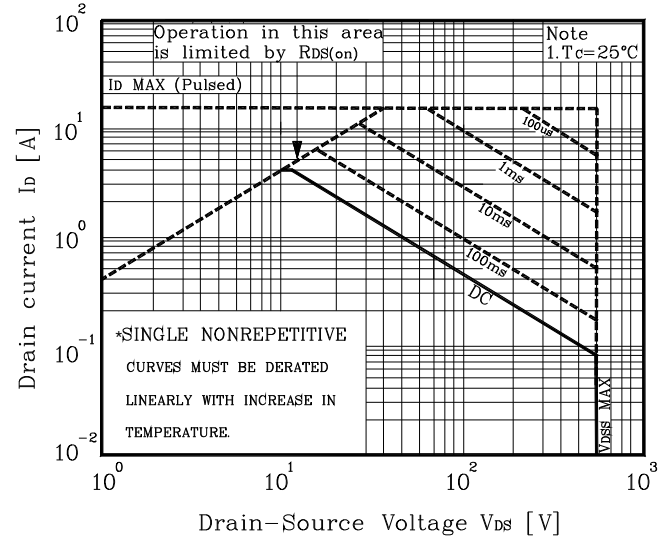


Fig. 11 Gate Charge Test Circuit & Waveform

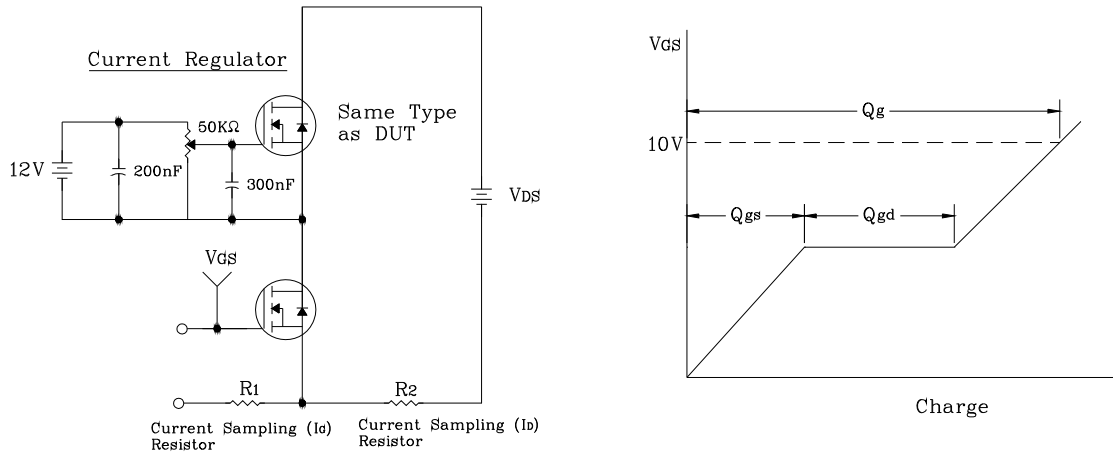


Fig. 12 Resistive Switching Test Circuit & Waveform

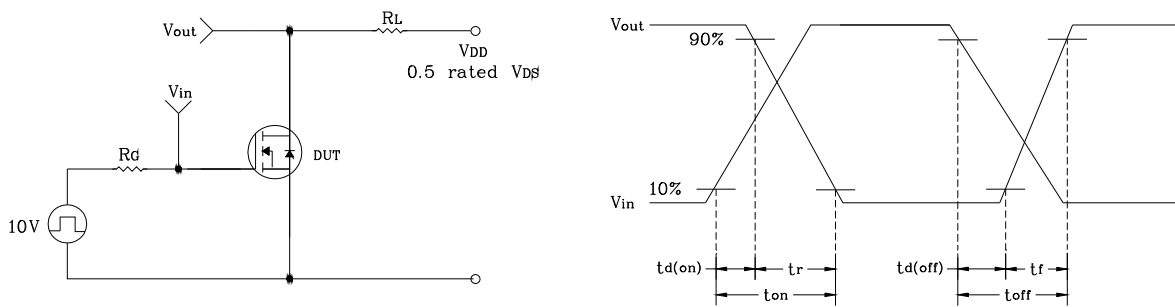


Fig. 13 E_{AS} Test Circuit & Waveform

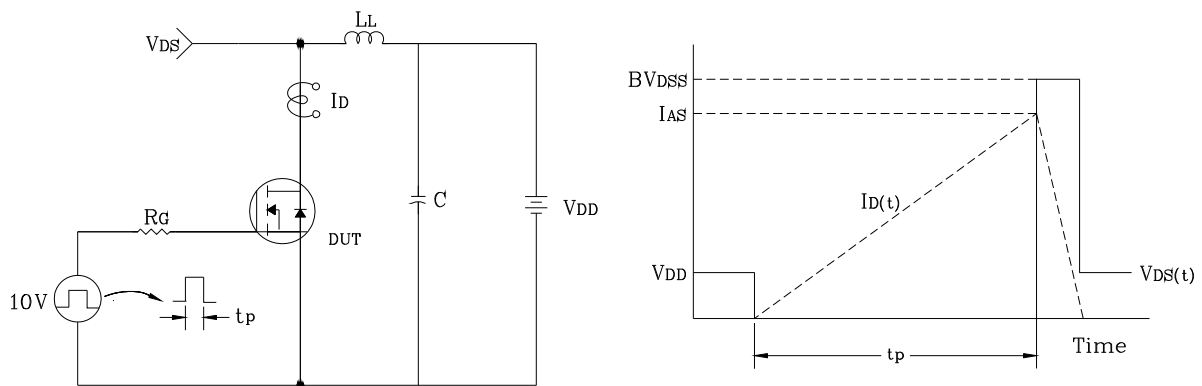
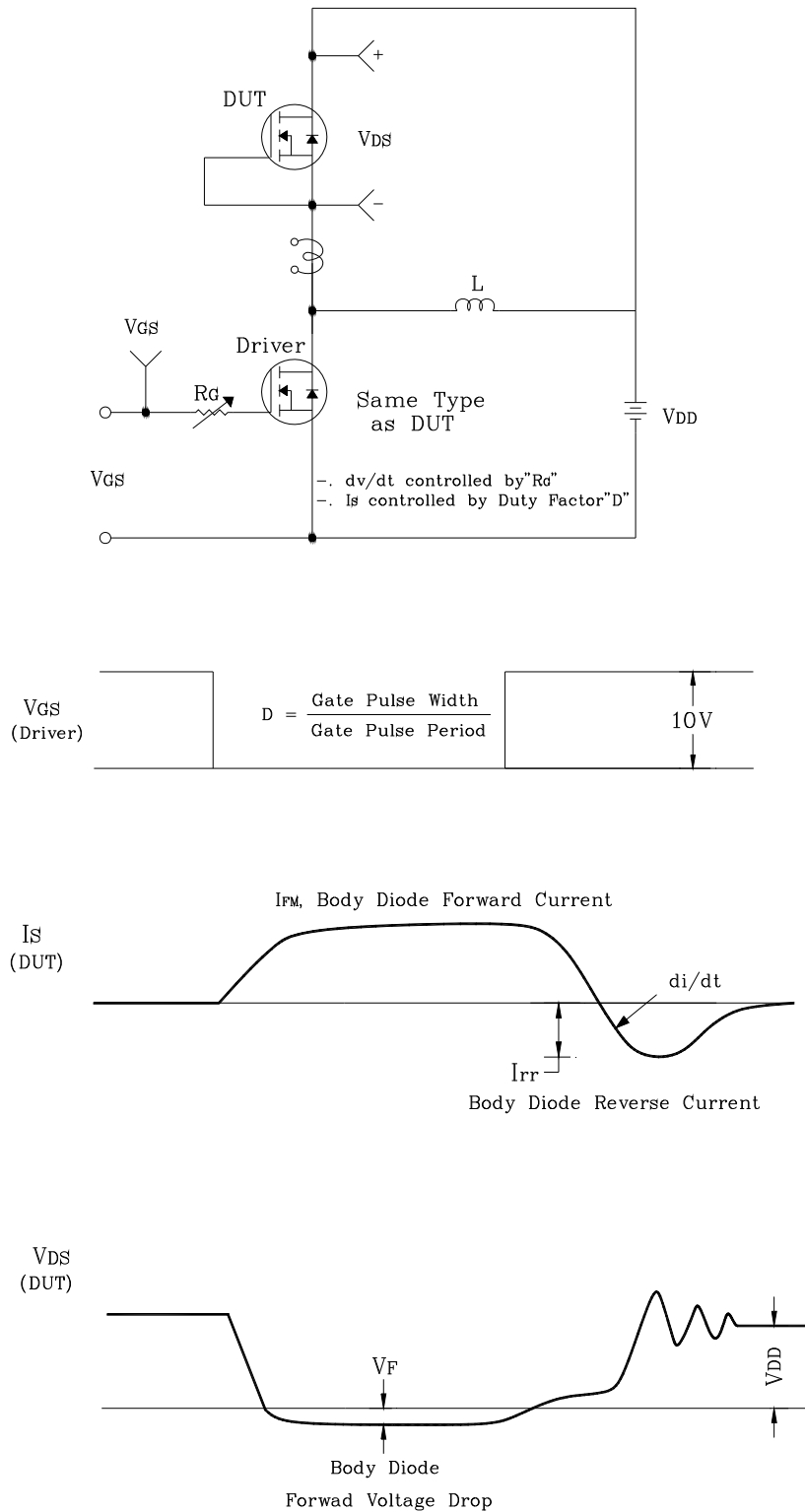
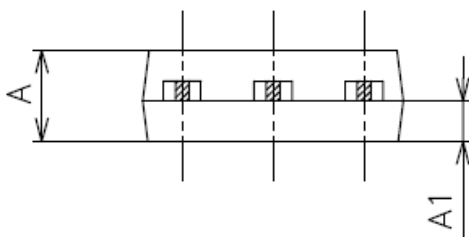
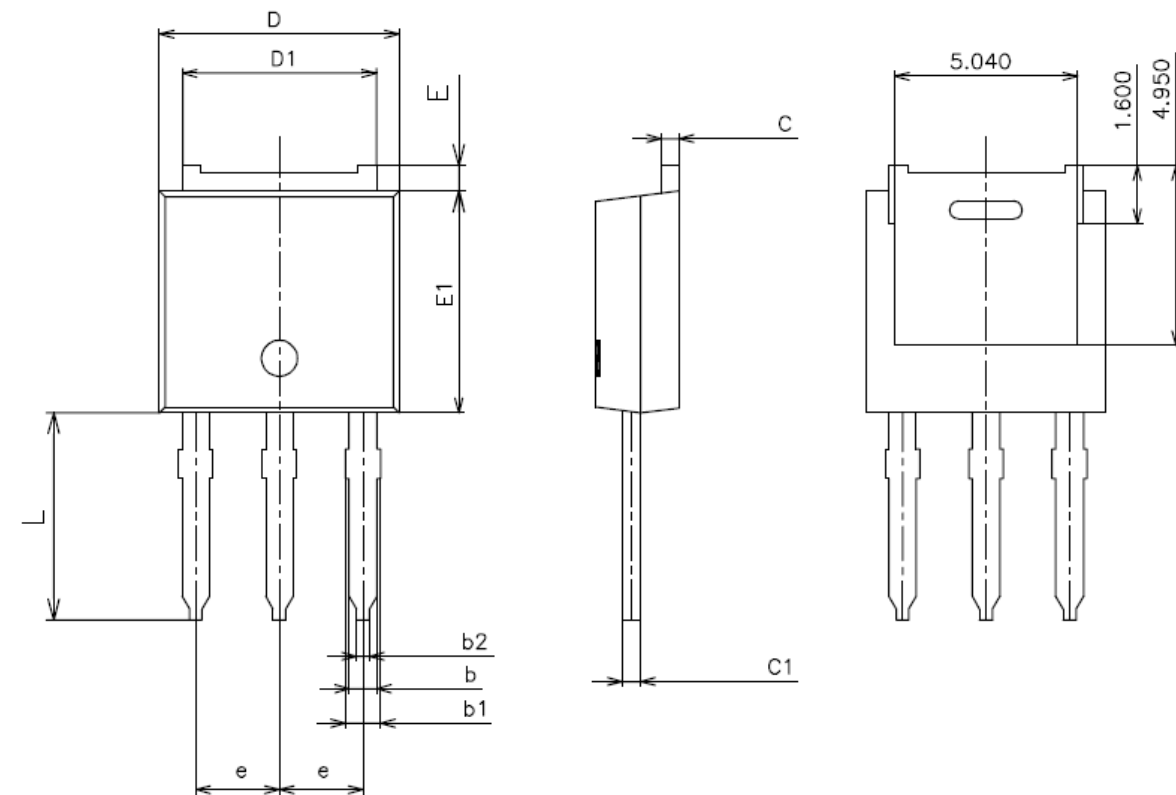


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform



Package Outline Dimensions



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
D	6.40	6.60	6.80	
D1	5.14	5.34	5.54	
E	0.50	0.70	0.90	
E1	5.90	6.10	6.30	
A	2.20	2.30	2.40	
A1	0.87	1.07	1.27	
C	0.40	0.50	0.60	
C1	0.40	0.50	0.60	
L	5.50	5.70	5.90	
b	0.66	0.76	0.86	
b1	0.82	1.02	1.22	
b2	0.25	0.35	0.45	
e	2.10	2.30	2.50	

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